

CMI-018

2832
PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Gabriel et al.

Appl. No. : 10/099,664

Filed : March, 15 2002

For : MODIFICATION OF
SELECTIVITY FOR SENSING
FOR NANOSTRUCTURE
SENSING DEVICE ARRAYS

Examiner : unknown



Group Art Unit: 2832

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first-class mail in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on

July 1, 2002

(Date)

David C. Cohen Reg. No. 43,554

SUBMISSION OF INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. §1.97(b)(3)

Assistant Commissioner for Patents
Washington, D.C. 20231

Dear Sir:

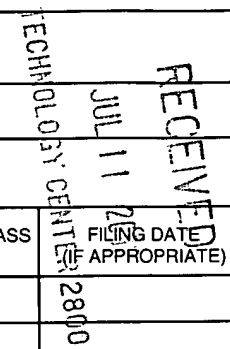
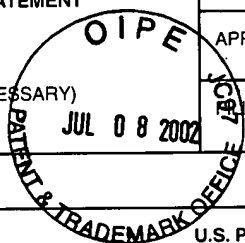
Applicant respectfully requests consideration of the enclosed Information Disclosure Statement and copies of the references therein in the examination of the above-referenced application. No fee is being submitted in accordance with 37 C.F.R. §1.97(b)(3).

Respectfully submitted,

Dated: July 1 2002

David C. Cohen
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Agent of Record
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FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	DOCKET NO. CMI-018	APPLICATION NO. 10/099,664
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)		APPLICANTS Gabriel et al	
		FILING DATE March 15, 2002	GROUP 2832



U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
		3,676,820	7/11/1972	Taguchi	338	34	
		3,831,432	8/27/1974	Cox	73	23	
		4,101,906	8/18/1978	Dahlstrom et al.	346	75	
		4,389,658	6,21,1983	Perna et al.	346	140	
		4,542,640	9/24/1985	Clifford	73	23	
		4,759,210	7/26/1988	Wohljen	73	23	
		5,571,401	11/5/1996	Lewis et al.	205	787	
		5,877,580	3/2/1999	Swierkowski	310	328	
		6,289,328	09/11/2001	Shaffer	706	20	
		6,312,097	11/6/2001	Brugman	347	40	
		6,321,588	11/27/2001	Bowers et al.	73	24.01	

FOREIGN PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
		WO 01/44796 A1	11/15/2000	PCT	G01N	27/12		
		WO 01/03208 A1	1/11/2001	PCT	H01L	45/00		
		WO 02/48701	6/20/02	PCT	G01N	27/00		

EXAMINER	DATE CONSIDERED
*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.	

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (USE SEVERAL SHEETS IF NECESSARY)	DOCKET NO. CMI-018	APPLICATION NO. 10/099,664
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EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
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	Bahr, J.L., Tour, J., "Highly Functionalized Carbon Nanotubes Using in situ Generated Diazonium Compounds," (2001) p. 3823.
	Bahr, J.L., Yang, J., Kosynkin, D., Bronikowski, M., Smalley, R., Tour, J., "Functionalization of Carbon Nanotubes by Electrochemical Reduction of Aryl Diazonium Salts: A Bucky Paper Electrode", J. Am. Chem. Soc. 123 (2001) p. 6536.
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	Kong, J, Franklin, N., Zhou, C., Chapline, M., Peng, S, Cho, K., Dai, H., "Nanotube Molecular Wires as Chemical Sensors," Science 287 (2000) p. 622.
	Martel, R; Derycket, V; Lavoie, C; Appenzeller, J; Chan, K.K; Tersoff, J; Avouris, P., Physical Review Letters 87 (2001) p. 256805-1.
	Nygaard, J; Cobden, D.H.; Applied Physics Letters 79 (2001) p. 4216.
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	Zhang, Y; Dai, H; Applied Physics Letters 77 (2000) p. 3015.
	Zhang, Y; Franklin, N.W.; Chen R.J.; Dai, H; Chemical Physics Letters 331 (2000) p. 35.

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